

ROHS COMPLIANT

Vishay Siliconix

P-Channel 8-V (D-S) MOSFET

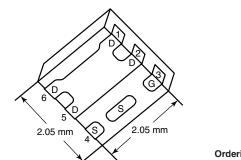
PRODUCT SUMMARY					
V _{DS} (V)	R_{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)		
- 8	0.023 at V _{GS} = - 4.5 V	- 12 ^a			
	0.031 at V _{GS} = - 2.5 V	- 12 ^a			
	0.040 at V _{GS} = - 1.8 V	- 12 ^a	19 nC		
	0.058 at V _{GS} = - 1.5 V	- 12 ^a			
	0.095 at V _{GS} = - 1.2 V	- 12 ^a			

FEATURES

- Halogen-free
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] SC-70 Package
 - Small Footprint Area
 - Low On-Resistance

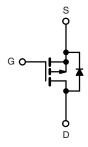
APPLICATIONS

Load Switch, PA Switch for Portable Devices



PowerPAK SC-70-6L-Single

Marking Code



Ordering Information: SiA417DJ-T1-GE3 (Lead (Pb)-free and Halogen-free)

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unles Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 8	V	
Gate-Source Voltage		V _{GS}	± 5		
Continuous Drain Current (T _J = 150 °C)	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	I _D	- 12 ^a - 12 ^a - 12 ^{a, b, c} - 8.3 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 30	-	
Continuous Source-Drain Diode Current	T _C = 25 °C T _A = 25 °C	I _S	- 12 ^a - 2.9 ^{b, c}	\neg	
Maximum Power Dissipation	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	P _D	19 12 3.5 ^{b, c} 2.2 ^{b, c}	w	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	28	36	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	5.3	6.5		

Notes:

a. Package limited

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SC-70 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 80 °C/W.

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SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless oth	erwise noted					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V_{GS} = 0 V, I_D = - 250 μ A	- 8			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	- Ι _D = - 250 μΑ		- 7.3		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	ι 200 μΑ		2.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 0.35		- 1	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 5 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -8 V, V_{GS} = 0 V$			- 1	μΑ	
		$V_{DS} = -8 V, V_{GS} = 0 V, T_{J} = 55 °C$			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS}{\leq}$ - 5 V, V_{GS} = - 4.5 V	- 10			А	
		V _{GS} = - 4.5 V, I _D = - 7 A		0.019	0.023	1	
	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 6 A		0.026	0.031	Ω	
Drain-Source On-State Resistance ^a		V _{GS} = - 1.8 V, I _D = - 5.3 A		0.033	0.040		
		V _{GS} = - 1.5 V, I _D = - 1.7 A		0.043	0.058		
		V _{GS} = - 1.2 V, I _D = - 1.1 A		0.063	0.095	1	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 4 V, I _D = - 7 A		23		S	
Dynamic ^b							
Input Capacitance	C _{iss}	iss		1600		1	
Output Capacitance	C _{oss}	V _{DS} = - 4 V, V _{GS} = 0 V, f = 1 MHz		500		pF	
Reverse Transfer Capacitance	C _{rss}			320			
Tatal Oata Obarra	Q _g Q _{gs} Q _{gd}	$V_{DS} = -4 V$, $V_{GS} = -5 V$, $I_{D} = -10 A$		21	32		
Total Gate Charge		V _{DS} = - 4 V, V _{GS} = - 4.5 V, I _D = - 10 A		19	29	nC	
Gate-Source Charge				2.2			
Gate-Drain Charge				5			
Gate Resistance	Rg	f = 1 MHz		8		Ω	
Turn-On Delay Time	t _{d(on)}			15	25		
Rise Time	t _r	$V_{DD} = -4 \text{ V}, \text{ R}_{\text{L}} = 0.5 \Omega$		25	38	-	
Turn-Off Delay Time	t _{d(off)}			80	120		
Fall Time	t _f			45	70		
Turn-On Delay Time	t _{d(on)}			10	15	ns	
Rise Time	t _r	V_{DD} = - 4 V, R_L = 0.5 Ω		12	20	-	
Turn-Off Delay Time	$t_{d(off)}$ I _D \cong - 8.3 A, V _{GEN} = - 5 V, R _g = 1 Ω			80	120		
Fall Time	t _f			45	70	1	
Drain-Source Body Diode Characterist	ics				·		
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			- 12	А	
Pulse Diode Forward Current	I _{SM}				- 30	A	
Body Diode Voltage	V _{SD}	I _S = - 8.3 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			60	90	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	– I _F = - 8.3 A, di/dt = 100 A/μs, T _J = 25 °C		33	50	nC	
Reverse Recovery Fall Time	t _a	$T_{\rm F} = -0.0$ A, $u_{\rm F}u_{\rm f} = -100$ A/µs, $T_{\rm J} = 20$ C		15			
Reverse Recovery Rise Time	t _b			45		ns	

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

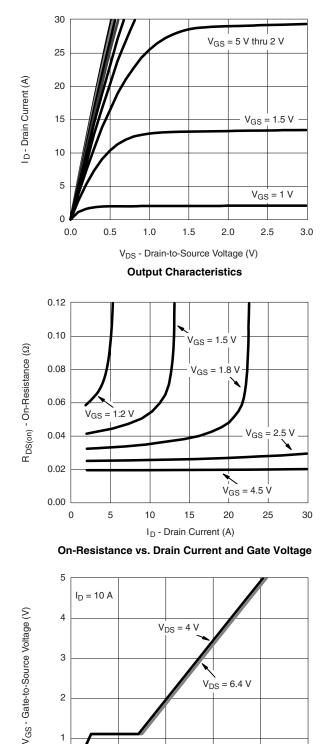
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

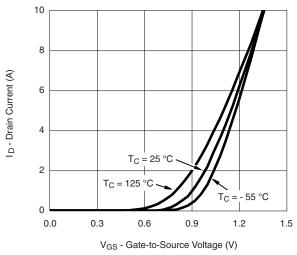




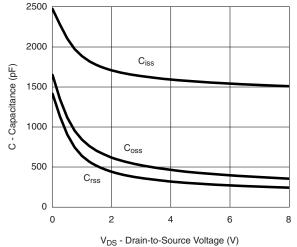
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

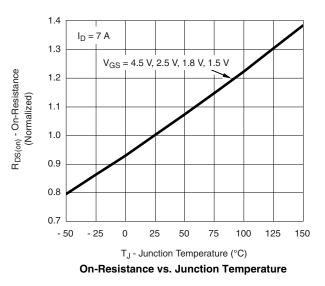




Transfer Characteristics



Capacitance



2

1

0

0

5

10

Qg - Total Gate Charge (nC)

Gate Charge

15

20

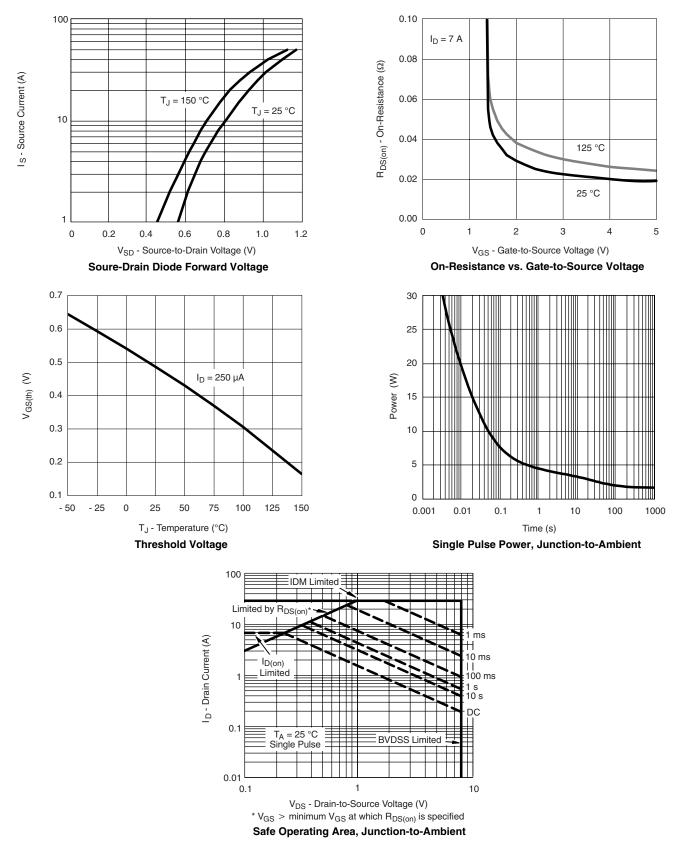
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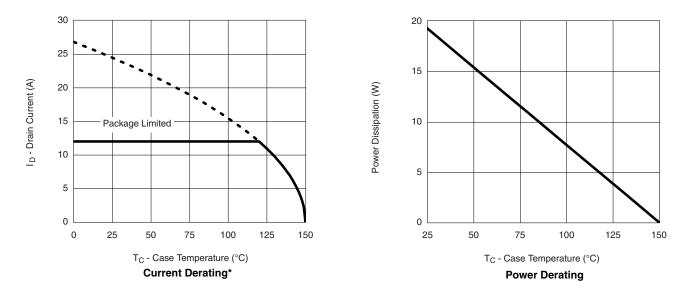






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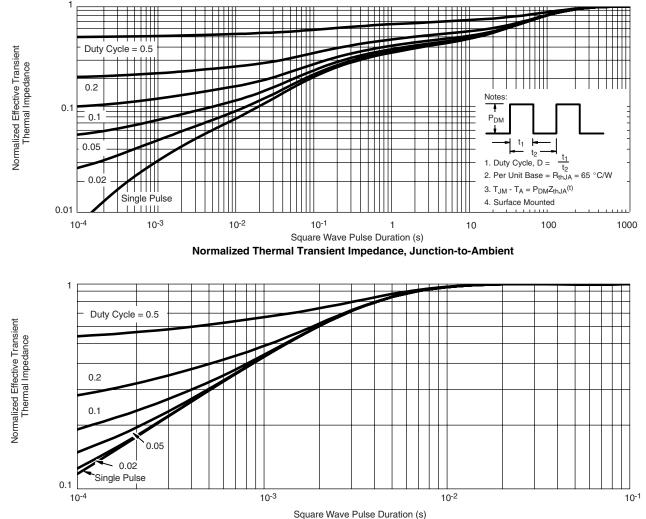
* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?74637.



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